

Dynamic Engineers Inc.

2550 Gray Falls Dr., Suite#128, Houston, TX, 77077 USA TEL: 1-281-870-8822 EMAIL:Sales@DynamicEng.com

Features and Benefits

High frequency stability(up to ±0.5 ppm over -40°C to +85°C) Low power consumption (up to 2 mA) DIL14 package design 5V Clipped Sine wave output

Typical Applications

Microwave Communication Mobile Devices

Description

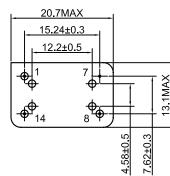
TCXO2013LCSG offers high frequency stability and low power consumption in DIL14 package with wide range of stability vs. operating temperature options to suit the different applications needs.

Mechanical Drawing & Pin Connections

Drawing No:

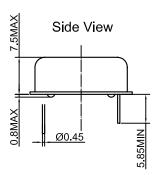
MD1400**-(

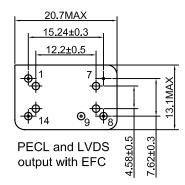
Bottom View



Pin Connections: (Without EFC)

PIN#	Symbol	CONNECTION			
1	N.C or Comp OUT	No Connection or Complementary RF Output (PECEL and LVDS)			
7	GND Ground				
8	RF OUT	RF Output			
9	Pin Not Present				
14	Vs	Supply Voltage			





Pin Connections: (With EFC)

PIN#	Symbol	CONNECTION			
1	Vc	Control Voltage(EFC)			
7	GND	GND Ground			
8	RF OUT	RF Output			
9	Comp OUT	Complementary RF Output (PECEL and LVDS)			
14	Vs	Supply Voltage			

Unit in mm 1 mm = 0.0394 inches



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TCXO&\$13LCS1 3.3V Clipped Sine Wave DIL14 TCXO

Specifications

Oscillator	Sym	Condition	Value			Heit	Note
Specification			Min.	Тур.	Max.	Unit	Note
Frequency Range			6		190	MHz	
Signal Waveform			Clip	ped Sine W	'ave		
Output Load				10 10		kΩ pF	
Amplitude			1			V p-p	
Power Supply							
Supply Voltage	Vs		4.75	5.00	5.25	V	
Current Consumption (Note 2)				2 ~ 30		mA	
Frequency Adjustment Range							
Mechanical (internal trimmer)			±3			ppm	Ordering Option = blank
Electronic Frequency Control (EFC)			±5			ppm	Ordering Option = "V"
EFC Voltage	V _C		0.5	2.5	4.5	V	
EFC Slope	$\Delta f / \Delta V_C$			Positive			
EFC Input Impedance			100			kΩ	
Frequency Stability							
Vs Operating Temperature			±0.5		±5.0	ppm	Refer to ordering options
Vs Supply Voltage changes	Vs	±5%		±0.1	±0.3	ppm	
Vs Load changes		±10%			±0.2	ppm	
Long Term Aging Per Year		@ +40°C			±1.0	ppm	
Environmental Conditions							
Operating Temperature Range			-40		+85	°C	Refer to ordering options
Storage Temperature Range			-55	-	+105	°C	
Enclosure (see drawing) L x W x H		max	20).7 x 13.1 x		mm	IEC 60679-3 CO2
Weight					5	g	

Notes:

- 1. Terminology and test conditions are according to IEC60679-1 and MIL-PRF-55310, unless otherwise stated
- 2. Depending on frequency and supply voltage
- 3. Reduced package height H = 5.1 mm max. on request
- 4. All combinations of options might not be available. Please consult DEI for details

Absolute Maximum Ratings

Parameter	Sym	Min	Max.	Unit	Condition
Supply Voltage	Vs	-0.5	V _S +10%	V	V _s to GND
Control Voltage	V_{C}	-0.5	6	V	V _c to GND

Handling and Testing

Parameter	Procedure		Condition
Electrostatic Discharge (ESD)			
THD devices	IEC60749-26	HBM	2000V
SMD devices	IEC60749-27	MM	200V
Washable	Yes		
RoHS Compliant	Yes		



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Ordering Options

Frequency Stability			erature wer)	Temperature (Upper)		
Code	Stability [ppm]	Code	T (°C)	Code	T (°C)	
1	±0.5	1	0	1	+50	
2	±1.0	2	-10	2	+60	
3	±1.5	3	-20	3	+70	
4	±2.0	4	-30	4	+75	
5	±2.5	5	-40	5	+80	
6	±3.0			6	+85	
7	±3.5					
8	±5.0					

Ordering Codes

Model	EFC	Frequency in MHz (up to 4 digits)	Frequency Stability	Minimum Operating Temperature	Maximum Operating Temperature
TCXO2013LCS2	_ or "V"	xxx.yyyy	t	w	Z

Example: TCXO2013LCS2-20.0000-5-5-6 has the following specifications

 $\begin{array}{ll} {\sf EFC} & = {\sf no \ EFC \ control} \\ {\sf Frequency} & = 20.0000 \ {\sf MHz} \\ {\sf Stability} & = \pm 2.5 \ {\sf ppm} \\ {\sf Operating \ Temperature} & = -40^{\circ}{\sf C \ to \ +85^{\circ}{\sf C}} \end{array}$

Environmental Conditions

Test	IEC 60068 Part	IEC 60679-1 Clause	MIL-STD- 202G Method	MIL-STD- 810F Method	MIL-PRF- 55310D Clause	Test Conditions (IEC)
Sealing tests (if applicable)	2-17	5.6.2	112E		3.6.1.2	Gross leak: Test Qc, Fine leak: Test Qk
Solderability Resistance to soldering heat	2-20 2-58	5.6.3	208H 210F		3.6.52 3.6.48	Test Ta Method 1 Test Td ₁ Method 2 Test Td ₂ Method 2
Shock	2-27	5.6.8	213B	516.4	3.6.40	Test Ea, 3 x per axes 100g, 6 ms half-sine pulse
Vibration sinusoidal	2-6	5.6.7.1	201A 204D	516.4-4	3.6.38.1 3.6.38.2	Test Fc, 30 min per axes, 10 Hz – 55 Hz 0,75mm; 55 Hz – 2 kHz, 10g
Vibration, random	2-64	5.6.7.3	214A	514.5	3.6.38.3 3.6.38.4	Test Fdb
Endurance tests - aging - extended aging		5.7.1 5.7.2	108A		4.8.35	30 days @+85°C 1000h, 2000h, 8000h @ +85°C